

**EAST Search History****EAST Search History (Prior Art)**

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L6	2	gotoh-masashi.in. and (growing near metal near plating)	US-PGPUB; USPAT	OR	ON	2009/07/17 09:53
L7	25	gotoh-masashi.in. and (electrode with conduct \$3)	US-PGPUB; USPAT	OR	ON	2009/07/17 09:55
L8	1	("5151168").PN.	US-PGPUB; USPAT	OR	OFF	2009/07/17 10:17
S1	1	("6370768").PN.	US-PGPUB; USPAT	OR	OFF	2009/07/16 11:08
S2	1920	(circuit near board or PCB or PWB) same ((fill\$3 same trench or open\$3) with electrode)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 11:11
S3	0	S2 same (electro? near plat\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 11:11
S4	0	S2 and (electro? near plat \$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 11:12
S5	100	S2 same ((lower\$3 or reduc\$3) same plat\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 11:15
S6	37	S5 and @pd<"20030630"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 11:16
S7	314	(single near2 plat\$3) same ((lower\$3 or reduc \$3) with (void or grow\$3 speed or rate))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 11:24

S8	175	S7 and @pd<"20030630"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 11:25
S9	11	S8 and (fill\$3 with (trench or open\$3 or groove or via or hole))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 11:26
S10	4	(single near layer near plat\$3) same ((lower\$3 or reduc\$3) with (void or grow\$3 speed or rate))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 11:27
S11	5	((single near layer near plat\$3) same (electrolytic near5 plat\$3)) same conduct\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 12:05
S12	779	(circuit near board or PCB or PWB) same ((electrolytic near5 plat\$3) same conduct\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 12:09
S13	495	S12 and (fil\$4 same (open \$3 or groove or hole or via))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 12:10
S14	159	S13 and @pd<"20030630"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 12:11
S15	47	S14 and electrode	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 12:31
S16	9	S14 and (electrode same (electro\$3 near plating))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 13:26
S17	101	((reduc\$3 or eliminat\$3) with void or gap) same (electrode same (electro\$3 near plating))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 14:44

S18	53	S17 and @pd< "20030630"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 14:45
S19	17	S18 and (metal near5 plat \$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2009/07/16 14:45
S20	1	"5874154".PN.	USPAT; USOCR	OR	ON	2009/07/16 15:05
S21	1	"5800858".PN.	USPAT; USOCR	OR	ON	2009/07/16 15:06
S22	1	"5660706".PN.	USPAT; USOCR	OR	ON	2009/07/16 15:06
S23	1	"5188723".PN.	USPAT; USOCR	OR	ON	2009/07/16 15:10
S24	2159	205/118-126.ccls. and @pd< "20030630"	US-PGPUB; USPAT	OR	ON	2009/07/16 16:02
S25	43	S24 and ((eliminat\$3 or reduc\$3) with void)	US-PGPUB; USPAT	OR	ON	2009/07/16 16:03
S26	0	S24 and (((eliminat\$3 or reduc\$3) with void) same electrode)	US-PGPUB; USPAT	OR	ON	2009/07/16 16:03
S27	1060	(((eliminat\$3 or reduc\$3) with void) same electrode)	US-PGPUB; USPAT	OR	ON	2009/07/16 16:04
S28	638	S27 and circuit	US-PGPUB; USPAT	OR	ON	2009/07/16 16:04
S29	186	S27 and (circuit with conduct\$3)	US-PGPUB; USPAT	OR	ON	2009/07/16 16:04
S30	16	S25 and electrode	US-PGPUB; USPAT	OR	ON	2009/07/16 16:07

**EAST Search History (Interference)**

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7/17/09 10:28:02 AM

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